

TYPES 2N3551, 2N3552 N-P-N TRIPLE-DIFFUSED MESA SILICON TRANSISTORS

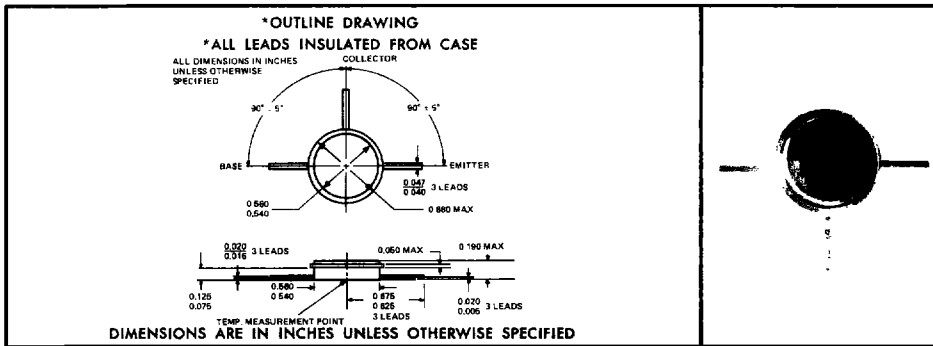
TYPES 2N3551, 2N3552
 BULLETIN NO. DL-5715883, AUGUST 1964
 REVISED DECEMBER 1971

HIGH-SPEED POWER SWITCH, ISOLATED COLLECTOR FORMERLY TIX210, TIX211

- 40 Watts at 100°C Case Temperature
- Maximum r_{CS} of 0.1 Ohm at 10 Amperes I_C
- Maximum V_{BE} of 1.4 Volts at 10 Amperes I_C
- Maximum t_{on} of 300 nsec

mechanical data

These transistors are in precision welded, hermetically sealed enclosures. Extreme cleanliness during the assembly process prevents sealed-in contamination. The approximate unit weight is 3.8 grams.



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*absolute maximum ratings at 25°C case temperature (unless otherwise noted)

	2N3551	2N3552
Collector-Base Voltage	115 v	140 v
Collector-Emitter Voltage (See Note 1)	60 v	80 v
Emitter-Base Voltage	← 7 v →	← 7 v →
Continuous Collector Current	← 12 a →	← 12 a →
Continuous Base Current	← 5 a →	← 5 a →
Continuous Emitter Current	← -12 a →	← -12 a →
Safe Operating Region at 100°C		
Case Temperature	See Figures 3 and 4	
Continuous Device Dissipation at (or below) 25°C		
Free-Air Temperature (See Note 2)	← 1.2 w →	
Continuous Device Dissipation at (or below) 100°C		
Case Temperature (See Note 3)	← 40 w →	
Operating Collector Junction Temperature	← 175°C →	
Operating Case Temperature Range	← -65°C to +175°C →	
Storage Temperature Range	← -65°C to +200°C →	
Lead Temperature 1/16 Inch from Case for 12 Seconds	← 235°C →	

NOTES: 1. These values apply when the base-emitter diode is open-circuited.
 2. Derate linearly to 175°C free-air temperature at the rate of 8 mw/°C.
 3. Derate linearly to 175°C case temperature at the rate of 0.53 w/°C.

*JEDEC registered data

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*electrical characteristics at 25°C case temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	2N3551		2N3552		UNIT
		MIN	MAX	MIN	MAX	
V_{CB0} Collector-Base Breakdown Voltage	$I_C = 10 \text{ ma}$, $I_E = 0$, See Note 4	115		140		v
V_{CE0} Collector-Emitter Breakdown Voltage	$I_C = 200 \text{ ma}$, $I_B = 0$, See Note 4	60		80		v
I_{CEV} Collector Cutoff Current	$V_{CE} = 110 \text{ v}$, $V_{BE} = -1.5 \text{ v}$		10			ma
	$V_{CE} = 135 \text{ v}$, $V_{BE} = -1.5 \text{ v}$			10		
	$V_{CE} = 60 \text{ v}$, $V_{BE} = -1.5 \text{ v}$, $T_C = 150^\circ\text{C}$		10			
	$V_{CE} = 80 \text{ v}$, $V_{BE} = -1.5 \text{ v}$, $T_C = 150^\circ\text{C}$				10	
I_{EBO} Emitter Cutoff Current	$V_{EB} = 5 \text{ v}$, $I_C = 0$		0.1		0.1	ma
	$V_{EB} = 7 \text{ v}$, $I_C = 0$		1		1	
h_{FE} Static Forward Current Transfer Ratio	$V_{CE} = 2 \text{ v}$, $I_C = 5 \text{ a}$, See Note 4	25		25		
	$V_{CE} = 2 \text{ v}$, $I_C = 10 \text{ a}$, See Note 4	20	90	20	90	
	$V_{CE} = 2 \text{ v}$, $I_C = 10 \text{ a}$, $T_C = -55^\circ\text{C}$, See Note 4	10		10		
V_{BE} Base-Emitter Voltage	$I_B = 0.5 \text{ a}$, $I_C = 5 \text{ a}$, See Note 4		1.2		1.2	v
	$I_B = 1 \text{ a}$, $I_C = 10 \text{ a}$, See Note 4		1.4		1.4	
$V_{CE(sat)}$ Collector-Emitter Saturation Voltage	$I_B = 0.5 \text{ a}$, $I_C = 5 \text{ a}$, See Note 4		0.5		0.5	v
	$I_B = 1 \text{ a}$, $I_C = 10 \text{ a}$, See Note 4		1.0		1.0	
$ h_{fe} $ Small-Signal Common-Emitter Forward Current Transfer Ratio	$V_{CE} = 10 \text{ v}$, $I_C = 3 \text{ a}$, $f = 10 \text{ Mc}$	4		4		
C_{ob} Common-Base Open-Circuit Output Capacitance	$V_{CB} = 10 \text{ v}$, $I_E = 0$, $f = 1 \text{ Mc}$		850		850	pf

NOTE 4: These parameters must be measured using pulse techniques. $PW = 300 \mu\text{sec}$, Duty Cycle $\leq 2\%$.

thermal characteristics

PARAMETER	MAX	UNIT
θ_{J-C} Junction-to-Case Thermal Resistance	1.875	$^\circ\text{C}/\text{w}$
θ_{J-A} Junction-to-Free-Air Thermal Resistance	125	$^\circ\text{C}/\text{w}$

*switching characteristics at 25°C case temperature

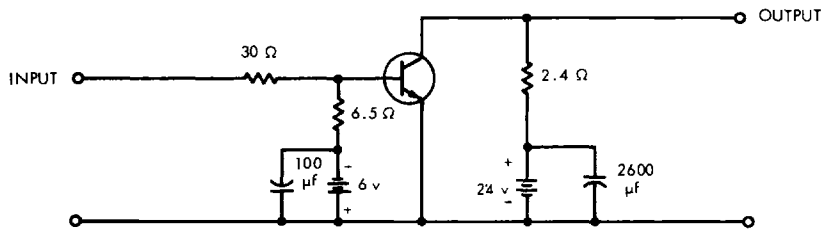
PARAMETER	TEST CONDITIONS‡	MAX	UNIT
t_{on} Turn-On Time	$I_C = 10 \text{ a}$, $I_{B(1)} = 1 \text{ a}$, $I_{B(2)} = -1 \text{ a}$	0.3	μSEC
t_{off} Turn-Off Time	$V_{BE(off)} = -6 \text{ v}$, $R_L = 2.4\Omega$, See Figure 1	2.5	μSEC

‡Voltage and current values shown are nominal; exact values vary slightly with device parameters.

*JEDEC Registered Data

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PARAMETER MEASUREMENT INFORMATION



TEST CIRCUIT

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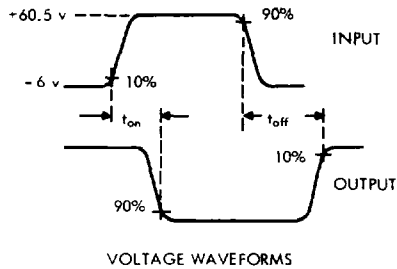


FIGURE 1

- NOTES: a. The input waveform is supplied by a generator with the following characteristics: $t_r \leq 20$ nsec, $t_f \leq 20$ nsec, $Z_{out} = 1500 \Omega$, $PW = 5 \mu\text{sec}$,
Duty Cycle $\leq 0.5\%$.
- b. Waveforms are monitored on an oscilloscope with the following characteristics: $t_r \leq 5$ nsec, $R_{in} \geq 1 \text{ M}\Omega$, $C_{in} \leq 5$ pF.
- c. Resistors must be noninductive types.

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THERMAL INFORMATION

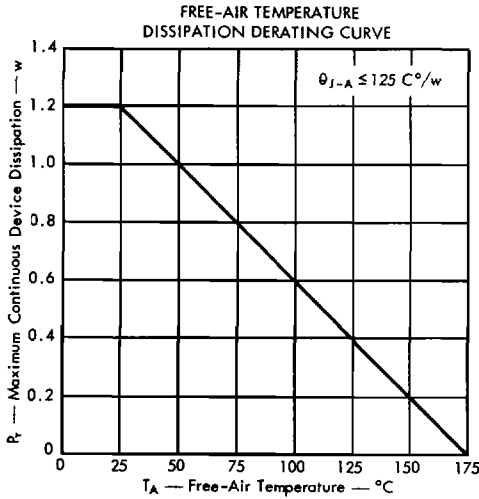


FIGURE 1

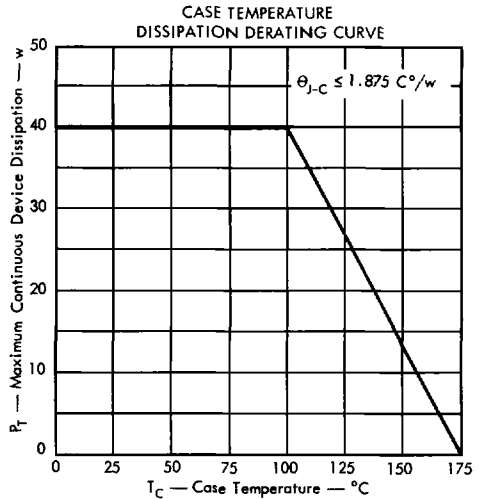


FIGURE 2

MAXIMUM SAFE OPERATING REGIONS

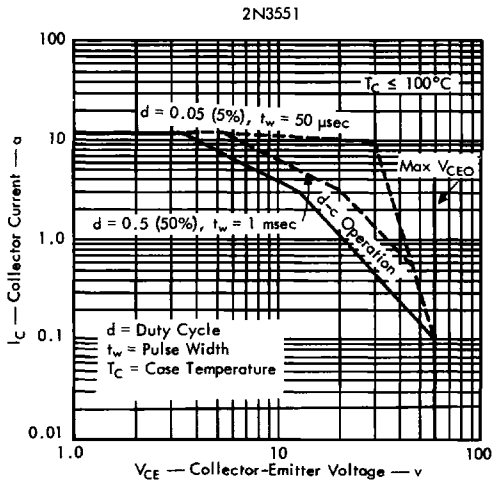


FIGURE 3

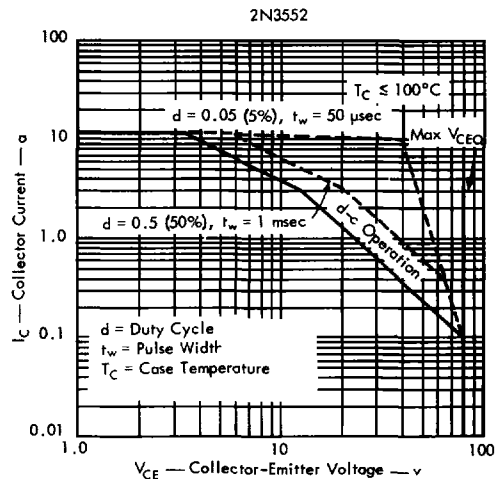


FIGURE 4